

ELECTRONIC AND OPTICAL PROPERTIES OF ZnO: FIRST PRINCIPLE INVESTIGATIONS

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ABSTRACT

Dielectric function and optical properties of oxide zinc (ZnO) nanostructure are studied by the first-principle computational within the framework of the density functional theory (DFT) using SIESTA code. The calculated lattice parameters and internal coordinates are in very good agreement with the experimental findings. Band structure, PDOS, real and imaginary parts of dielectric function, reflectance and absorbance has been calculated. A comparison with the previous studies has been made.

Keywords: Density Functional Theory, Siesta, Optical properties, Dielectric function.

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1. INTRODUCTION

Zinc oxide is a direct wide band gap ($\Delta E = 3.37$ eV) semiconductor with a large excitation binding energy of 60 meV, which makes ZnO an attractive versatile material applied in

Photodiodes [1], photocatalysis [2], sensing [3-4] and photovoltaic cells [5-6]. Mesoporous materials have found a large number of significant benefits due to their large surface area and well organized porous mesostructure. The physical properties of mesoporous ZnO could be improved leading to high optical quality, low refractive index, photoluminescent, small crystal sizes and better photocatalytic activity [7].

The no central symmetry and the tetrahedral coordinated ZnO unit in ZnO result in anisotropic piezoelectric properties. Structurally, the wurtzite structured ZnO crystal is described schematically as a number of alternating planes composed of four-fold coordinated O^{2-} and Zn^{2+} ions, stacked alternatively along the c-axis. The oppositely charged ions produce positively charged (0001)-Zn and negatively charged (000 $\bar{1}$)-O polar surfaces, resulting in a normal dipole moment and spontaneous polarization as well as a divergence in surface energy. To maintain a stable structure, the polar surfaces generally have facets or exhibit massive surface reconstructions, but ZnO (0001) is an exception, which is atomically flat, stable, and without reconstruction [8-9]. Understanding the superior stability of the ZnO (0001) polar surfaces is a forefront research in today's surface physics [10-13].

Transparent conducting zinc oxide (ZnO) thin films have extensively studied in the last years due to their interesting properties such as high transmission coefficient in visible and high reflection of infrared radiation, direct optical band-to-band transitions, low electrical resistivity, etc [14-21].

In this paper, we used the density-functional theory (DFT) to investigate the structural, electronic, and optical properties of the ZnO nanostructure. The study may provide some useful information for future investigations in oxide metal catalysts.

2. COMPUTATIONAL DETAILS

Our calculations are performed using the first-principles pseudo potential method based on the density functional theory (DFT) within the generalized gradient approximation (GGA) as implemented in the SIESTA [22,23]. The GGA-PBE exchange-correlation functional, as parameterized by Wang, Perdew and Ernzerhof, is employed [24]. In the case of LCAO calculations (SIESTA), the pseudo potentials reconstructed by the Troullier–Martins scheme[25]. The double- ζ plus polarization basis set search for Zn and O respectively. A real space mesh cutoff of 300 Ry and a reciprocal space grid cut-off of approximately 15\AA were used. The structure relaxation was done using the conjugated gradient method until the Hellman Feynman force on each atom is smaller than $0.05\text{eV}/\text{\AA}$. The Gamma centered grid of $(6 \times 6 \times 1)$ k points was used for the Brillouin zone integration during geometry relaxation. To calculate the optical properties, a grid of $(9 \times 9 \times 1)$ k points was used. For the bulk ZnO, the calculated lattice constants are 3.284\AA and 5.330\AA , which are in reasonable agreement with the corresponding experimental values (3.250\AA and 5.207\AA) [26]

3. RESULTS AND DISCUSSION

3.1 Unit Cell Structure

Unit cell structure ZnO stable (B4) structure having hexagonal primitive unit cell with space group $C4\ 6v\ P63_{mc}$. Each primitive unit cell of ZnO consists of four atoms where two Zn atoms are at the positions $(1/3, 2/3, 0)$, $(1/3, 2/3, 1/2)$ and O atoms at the positions $(1/3, 2/3, \mu)$, $(1/3, 2/3, \mu + 1/2)$, μ is the internal parameter of the B4 phase that determines the bond-length (anion-cation bond length) parallel to c-axis divided by the c-lattice parameter.

$$\mu = \left(\frac{1}{4} + \left(\frac{c^2}{3a^2}\right)\right) \quad (1)$$

The bulk parameters of ZnO are calculated to be: $a = 3.284\ \text{\AA}$, $c = 5.330\ \text{\AA}$, and $E_g = 0.65\ \text{eV}$ which is in reasonable agreement with the previous DFT calculation with $a = 3.283\ \text{\AA}$, $c = 5.289\ \text{\AA}$ [27]. Table 1 shows the results of a, b, c/a and band gap (E_g).

From the table 1, we can note that our results with GGA are in good agreement the other theoretical Results [28-30], the value of band gap is found lower than the experimental values, this is regarded as a spread problem of DFT calculations.

Table 1. Calculated lattice parameters of ZnO in phase (wurtzite) in comparison with other theoretical values available.

Method	Code	a (Å)	c (Å)	c/a	E_g (ev)
This work	Siesta: GGA	3.284	5.330	1.623	0.65
Ref[28]	Transiesta: GGA	3.288	5.270	1.603	1.02
Ref[29]	Wien2k: GGA	3.300	5.346	1.620	0.69
Ref[30]	Wien2k: GGA	3.240	5.200	1.602	1.20

3.2 Band Structure

The band structure of ZnO in wurtzite is evaluated using calculated lattice parameters ($a = 3.284 \text{ \AA}$, $c = 5.330 \text{ \AA}$). It can be seen that the valence band maxima and conduction band minima lie on the same Γ point, indicating direct band with value 0.65 eV.

Calculated band gap values with GGA are smaller than experimental results, which indicate that this form of GGA is not sufficiently flexible to give consistent results for band gap energy similar to other forms of GGAs and LDA. Our calculated band gap value for wurtzite is in good agreement with Similar to the result of the theory [30], and about 60.00% less than that of experimentally reported band gap values [31]. The band structure is illustrated in figure 1.

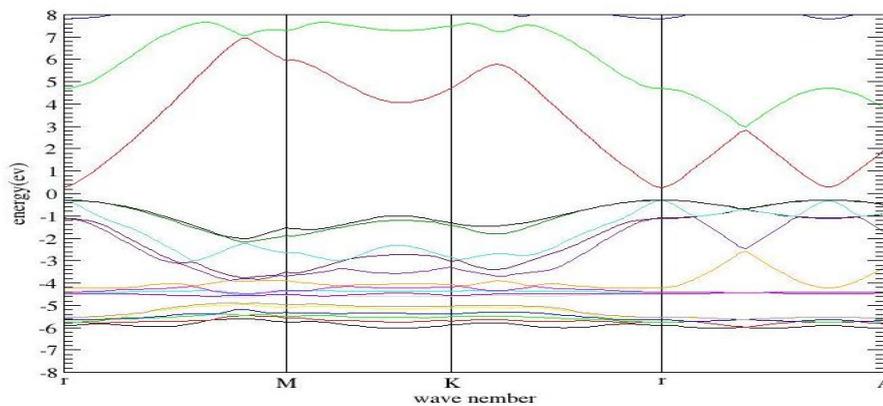


Fig.1. Band structure of ZnO for wurtzite.

3.3 Density Of States

Figure 2 shows the partial densities of states of ZnO. From this figure, We can say that the presence of density of states peaks in the valence band region is mainly due to the 3d orbital of the zinc element (Zn) and the p orbital of the oxygen (O), while the small peaks observed within the conduction band region are essentially due to the p orbital of the zinc (Zn) and the participation of s and p orbitals of the zinc (Zn) and (O) Respectively. Therefore, d orbital of zinc and p orbital of oxygen are the cause of the presence of the density of the orbital in the valence band region but the contribution of d orbital is predominant.

We can also see the emergence of bonding level near the Fermi level at energy of -1.8 eV and also an anti-bonding level near to energy of 2 eV, which makes the possibility of electron transmission from the valence band to the conduction band if the oxide is exposed to external stimulation such as light.

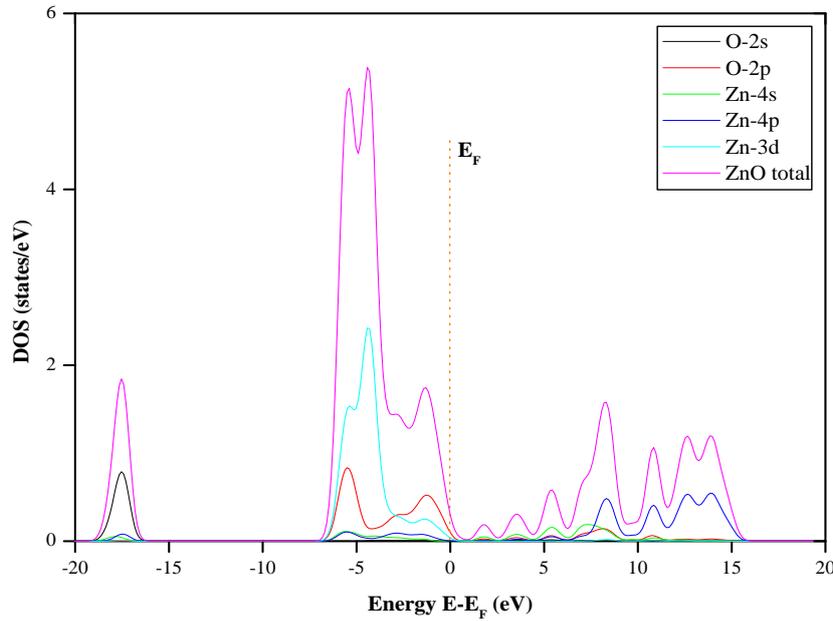


Fig.2. Partial DOS (states/eV).

3.4 Optical Properties

3.4.1 Real and Imaginary parts Of Dielectric Function

Optical properties play an active role in the understanding of the nature of material and provide a clear picture for the usage of a material in optoelectronic devices. It is generally known that the interaction of a photon with the electrons in the system can be described in terms of time dependent perturbations of the ground-state electronic states. Transitions between occupied and unoccupied states are originated by the electric field of the photon. The optical response of a material to the electromagnetic field at all energy levels can be described by means of complex dielectric function $\varepsilon(\omega)$ as:

$$\varepsilon(\omega) = \varepsilon_1(\omega) + i\varepsilon_2(\omega) \quad (2)$$

Where, $\varepsilon_1(\omega)$ and $\varepsilon_2(\omega)$ are real and imaginary part of the dielectric function. Real part of the dielectric function $\varepsilon_1(\omega)$, means the dispersion of the incident photons by the material, while the imaginary part of the dielectric function, $\varepsilon_2(\omega)$, corresponds to the energy absorbed by the material. There are two contributions to complex dielectric function $\varepsilon(\omega)$, namely intraband and interband transitions. The contribution from intraband transitions is influential only for

metals. The interband transitions can be further divided into direct and indirect transitions [20,32]. The imaginary part $\epsilon_2(\omega)$ of the dielectric function is calculated from the contribution of the direct interband transitions from the occupied to unoccupied states and the calculation is associated with the energy eigen value and energy wave functions, which are the direct output of band structure calculation.

Figure 3 shows the plot of real and imaginary part of dielectric function. The imaginary part of the dielectric tensor can be computed by the knowledge of the electronic band structure of the solid. The imaginary part of the dielectric function, as displayed, indicate that there is no optical adsorption in the low-energy region (0-0.65 eV) for both polarizations but for further energies, there is optical adsorption and strong anisotropy in the optical spectra.

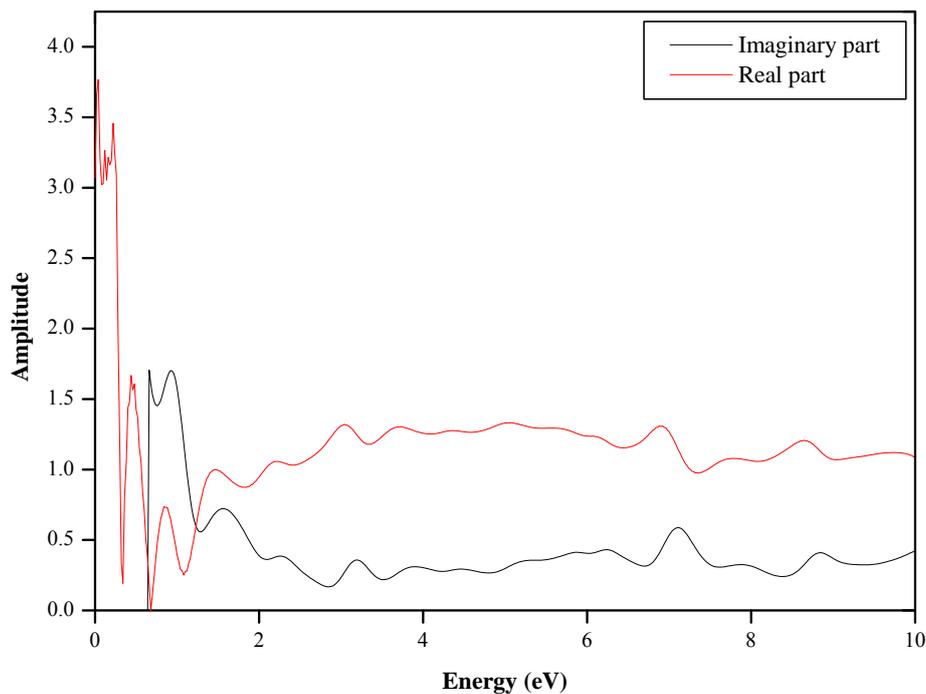


Fig.3. Plot of real and imaginary part of dielectric function.

3.4.2 Reflectance And Absorption

The reflectance and absorption values of the ZnO have been calculated. Figure 4 shows that the reflectance values increase with wavelength in the range of [1130 nm-1500] until reaches its highest value at wavelength 1200 nm, It also decrease to reaches very small values of approximately 4% of the value of the beam received within the visible rang. The same Figure

shows the absorption of this oxide, which is similar to that found by V. Jan-Christoph Deinert [2933], where the absorption of radiation for this oxide is high in infrared region and reaches its maximum in the range of [1350 nm-1200]. This makes the ZnO suitable for use as an infrared detector and at the same time as conductor if the absorbed energy of these wavelengths is greater than its gap energy. Then, their values decrease to a wavelength of 950 nm and rise a little in a small wavelength range, afterward it regresses again.

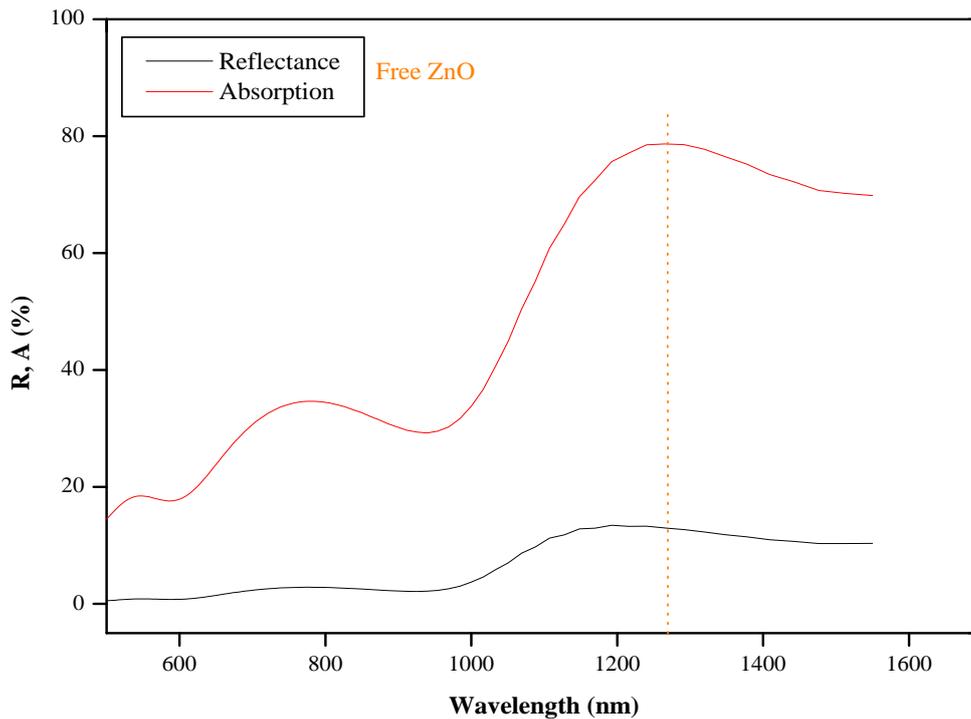


Fig.4. Absorption and reflectance as a function of the wavelength of ZnO.

4. CONCLUSION

Structural, electronic, and optical properties of the ZnO are studied using first principle DFT methods. The calculated lattice parameters and internal coordinates are in agreement with the experimental results. The band structure shows ZnO have direct band with value 0.65 eV. The movement of electrons near Fermi level shows mainly due to the 3d orbital of the zinc (Zn) and the p orbital of the oxygen (O). These electronic and dielectric properties of ZnO nanostructure can be useful for the applications in microelectronics and optoelectronic devices.

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